Feature selection

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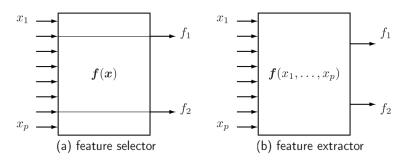


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Feature selection

Feature selection is a process of selecting a subset of original features with minimum loss of information related to final task (classification, regression, etc.)



Applications of feature selection

- increase predictive accuracy of classifier
- increase computational efficiency
- reduce cost of future data collection
- make classifier more interpretable

Types of features

- Let f be the feature, $\chi = \{f_1, f_2, ... f_D\}$ is the full set of features, $S = \chi \setminus \{f\}$
- Strongly relevant feature:

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$$p(y|f,S) \neq p(y|S)$$

Weakly relevant feature:

$$p(y|f,S) = p(y|S)$$
, but $\exists S' \subset S : p(y|f,S') = p(y|S')$

• Irrelevant feature:

$$\forall S' \subset S : p(y|f,S') = p(y|S')$$

Complexity

- ullet We seek optimal subset of m features $\hat{\mathcal{F}}_m$
- ullet χ_m is a set of all subsets of features of size m
- It is equal to

$$\hat{F}_m = \arg\max_{F \in \chi_m} J(X)$$

• Requires $\begin{pmatrix} D \\ m \end{pmatrix}$ checks!

Types of feature selection algorithms

- Completeness of search:
 - Optimal
 - Suboptimal
 - deterministic
 - random
- Classifier dependency
 - independent (filter methods)
 - uses classifier output (wrapper methods)
 - is embedded inside classifier (embedded methods)

Properties of each type

- filter methods
 - rely only on measures of dependency between features and output
 - do not take final quality measure into account (like misclassification rate)
 - are computationally efficient
- wrapper methods
 - subsets of variables are evaluated with respect to the quality of final classification
 - give better performance than filter methods
 - more computationally demanding
- embedded methods
 - feature selection is built into the classifier.
 - feature selection and model tuning are done jointly
 - ullet example: classification trees, methods with L_1 regularization.

Specification

- Need to specify:
 - quality criteria J(X)
 - ullet subset generation method $X_1, X_2, X_3, ...$

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Quality criteria (filter methods)

Peature subsets generation

Correlation

• two class:

$$\rho(f,y) = \frac{\sum_{i} (f_{i} - \bar{f})(y_{i} - \bar{y})}{\left[\sum_{i} (f_{i} - \bar{f})^{2} \sum_{i} (y_{i} - \bar{y})^{2}\right]^{1/2}}$$

• multiclass $\omega_1, \omega_2, ...\omega_C$

$$R^{2} = \frac{\sum_{c=1}^{C} \left[\sum_{i} (f_{i} - \bar{f})(y_{ic} - \bar{y}_{c}) \right]^{2}}{\sum_{c=1}^{C} \sum_{i} (f_{i} - \bar{f})^{2} \sum_{i} (y_{ic} - \bar{y}_{c})^{2}}$$

- Properties:
 - simple to compute
 - takes into account only linear relationships

Mutual information

• Entropy of feature X:

$$H(X) = -\sum_{x} p(x) \ln p(x)$$

• Entropy of X after observing Y:

$$H(X|Y) = -\sum_{y} p(y) \sum_{x} p(x|y) \ln p(x|y)$$

Mutual information - how much Y gives information about X:

$$MI(X,Y) = H(X) - H(X|Y)$$

$$= \sum_{x,y} p(x,y) \ln \left[\frac{p(x,y)}{p(x)p(y)} \right]$$

$$= H(Y) - H(Y|X) = MI(Y,X)$$

• MI is Kullback-Leibler divergence, so it is non-negative

Mutual information

Symmetrical uncertainty:

$$SU(X,Y) = 2\left(\frac{MI(X,Y)}{H(X) + H(Y)}\right)$$

- SU(X, Y) lies between 0 (independence) and 1 (full dependence)
- Properties of MI and SU:
 - identifies arbitrary non-linear dependencies
 - requires calculation of probability distributions
 - continuous variables need to be discretized

Other criteria

- Probabilistic distance: $p(x|\omega_1)$ vs. $p(x|\omega_2)$
- Probabilistic dependence: $p(x|\omega_i)$ vs. p(x)
- Metric separability of classes:

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$$S_W = \sum_{c=1}^{C} \frac{N_c}{N} \Sigma_c$$
, $S_B = \sum_{c=1}^{C} \frac{N_c}{N} (m_j - m) (m_j - m)$

• metrics: $Tr\{S_W^{-1}S_B\}$, $\frac{Tr\{S_B\}}{Tr\{S_W\}}$

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Quality criteria (filter methods)

Peature subsets generation

Complete search with optimal solution

- exhaustive search
- branch and bound method
 - requires monotonicity property:

$$F \subset G : J(F) < J(G)$$

example

Incomplete search with suboptimal solution

• Order features with respect to J(f):

$$J(f_1) \geq J(f_2) \geq ... \geq J(f_D)$$

select top m

$$\hat{F} = \{f_1, f_2, ... f_m\}$$

• select best set from nested subsets:

$$S = \{\{f_1\}, \{f_1, f_2\}, ...\{f_1, f_2, ...f_D\}\}$$

$$\hat{F} = \arg\max_{F \in S} J(F)$$

Sequential search

- Sequential forward selection algorithm:
 - init: $k = 0, F_0 = \emptyset$
 - while k<max_features:</p>
 - $f_{k+1} = \operatorname{arg} \max_{f \in \chi} J(F_k \cup \{f\})$
 - $F_{k+1} = F_k \cup \{f_{k+1}\}$
 - if $J(F_{k+1}) < J(F_{k-1})$: break
 - return F_k
- Variants:
 - sequential backward selection
 - up-k forward search
 - down-p backward search
 - up-k down-p composite search
 - up-k down-(variable step size) composite search

Other

- Random feature sets selection:
 - new feature subsets are generated completely at random
 - does not get stuck in local optimum
 - low probability to locate small optimal feature subset
 - sequential procedure of feature subset creation with inserted randomness
 - may get stuck in local optimum
 - more efficiently locates small optimal feature subsets
- Compositions
- Stability measures:
 - different algorithms
 - different subsamples